

Search Notes

Application/Control No.

10/707,361

Examiner

Mathieu D. Vargot

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

1732

SEARCHED

Class	Subclass	Date	Examiner
264	1.1, 2.5, 8.5, 1.34	3/4/06	MDV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR